

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/789,055	JUNG ET AL.	
Examiner	Art Unit	_
Sin J. Lee	1752	

	SEARCHED					
Class	Subclass	Date	Examiner			
430	325	7-10 -05	SJL			
	326					
	330					
	3//					
	905					
<u> </u>	914					
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
Structure Search for the compounds of 01.#13	4/6/06	SJL			
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